

## P-Channel Enhancement Mode Power MOSFET

## **Description**

The PTTT  $\in$ J uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , This device is suitable for use as a load switch or in PWM applications.

## **General Features**

•  $V_{DS} = -30V, I_{D} = -15A$ 

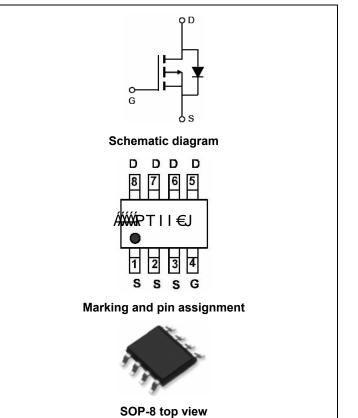
 $R_{DS(ON)}$  < 10m $\Omega$  @  $V_{GS}$ =-10V

 $R_{DS(ON)}$  <15m $\Omega$  @  $V_{GS}$ =-4.5V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

## **Application**

- PWM applications
- Load switch
- Uninterruptible power supply



**Package Marking and Ordering Information** 

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
PTII€J	PTII€J	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (T<sub>A</sub>=25 °Cunless otherwise noted)

7 to contact maximum reasons ( r.g. = 0 contact contact maximum reasons)						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V <sub>DS</sub>	-30	V			
Gate-Source Voltage	V <sub>G</sub> S	±20	V			
Drain Current-Continuous	I <sub>D</sub>	-15	Α			
Drain Current-Pulsed (Note 1)	I <sub>DM</sub>	-80	А			
Maximum Power Dissipation	P <sub>D</sub>	3.1	W			
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$ C			

### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	R <sub>θJA</sub>	40	°C/W
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Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-30	-33	-	V





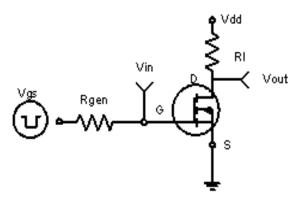
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V,V <sub>GS</sub> =0V	-	-	-1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-1.0	-1.75	-2.2	V
Drain Course On State Besistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-15A	-	8	10	mΩ
Drain-Source On-State Resistance		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-8A	-	11.5	15	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =-5V,I <sub>D</sub> =-15A	30	-	-	S
Dynamic Characteristics (Note4)			•			
Input Capacitance	C <sub>lss</sub>	\/ - 15\/\/ -0\/	-	2900	-	PF
Output Capacitance	Coss	$V_{DS}$ =-15V, $V_{GS}$ =0V, F=1.0MHz	-	410	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UNIFIZ	-	280	-	PF
Switching Characteristics (Note 4)			•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	15	-	nS
Turn-on Rise Time	t <sub>r</sub>	V <sub>DD</sub> =-15V, ID=-10A,	-	11	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10V, $R_{GEN}$ =3 $\Omega$	-	44	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	21	-	nS
Total Gate Charge	Qg		-	48	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-15V,I <sub>D</sub> =-10A,V <sub>GS</sub> =-10V	-	12	-	nC
Gate-Drain Charge	$Q_{gd}$		-	14	-	nC
Drain-Source Diode Characteristics	•		•	•		
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-2A	-	-	-1.2	V

#### **Notes**

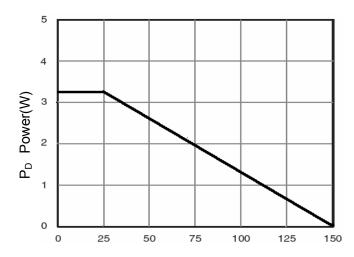
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



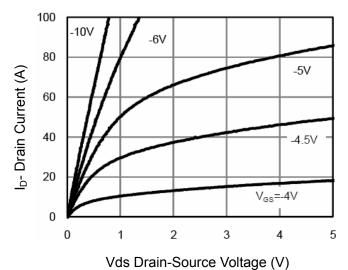
# **Typical Electrical and Thermal Characteristics**



**Figure 1 Switching Test Circuit** 



 $T_J$ -Junction Temperature(°C) Figure 3 Power Dissipation



**Figure 5 Output Characteristics** 

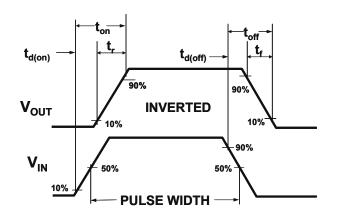


Figure 2 Switching Waveforms

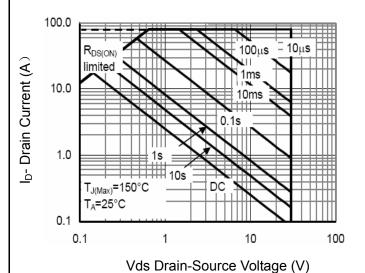


Figure 4 Safe Operation Area

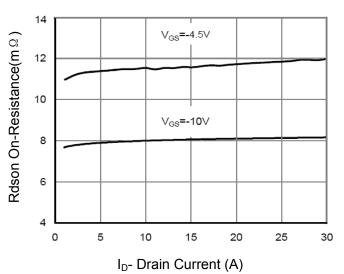
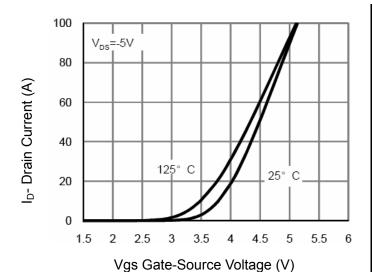
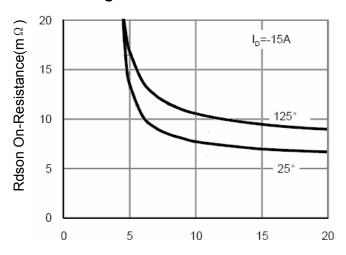


Figure 6 Drain-Source On-Resistance





**Figure 7 Transfer Characteristics** 



Vgs Gate-Source Voltage (V)
Figure 9 Rdson vs Vgs

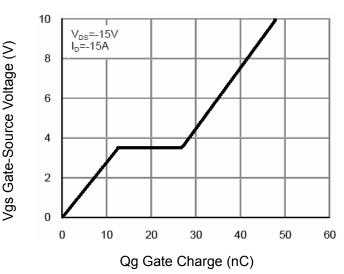
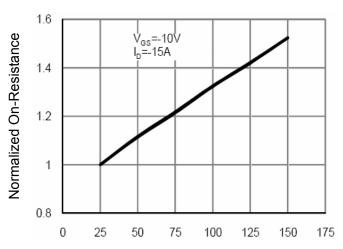


Figure 11 Gate Charge



T<sub>J</sub>-Junction Temperature(℃)

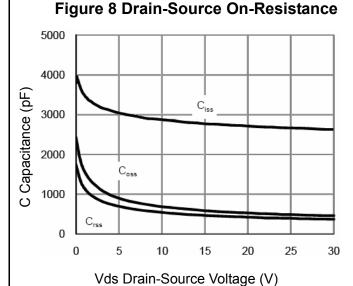


Figure 10 Capacitance vs Vds

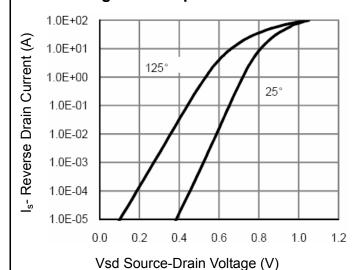


Figure 12 Source- Drain Diode Forward



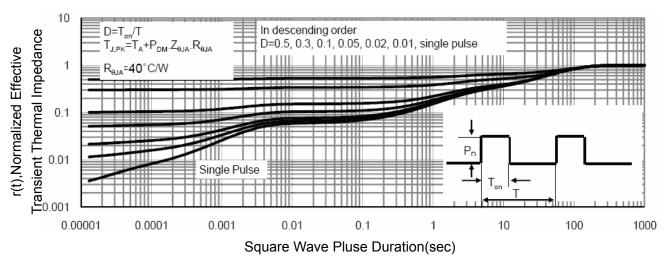
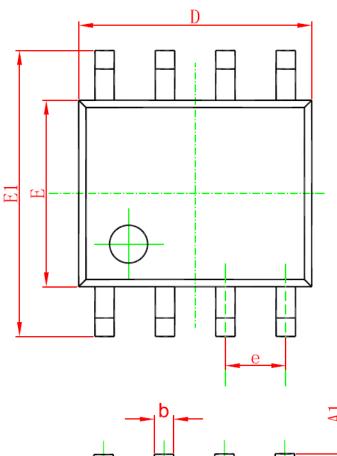
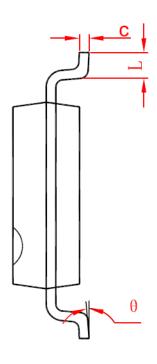


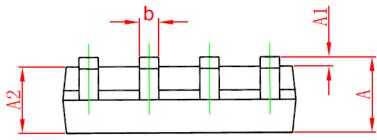
Figure 13 Normalized Maximum Transient Thermal Impedance



# **SOP-8 Package Information**







Ch l	Dimensions In	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
Е	3. 800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270	(BSC)	0. 050 (BSC)		
L	0. 400	1. 270	0. 016	0. 050	
θ	0°	8°	0°	8°	





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